Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	_
09/945,171	SMITH ET AL.	
Examiner	Art Unit	
Erin M. File	2611	

SEARCHED					
Class	Subclass	Date	Examiner		
375	297	6/25/2006	EMF		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	1				
			1		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM (text search only—see search history printout)	6/25/2006	EMF		